# MSKSEMI 美森科













ESD

TVS

TSS

MOV

GDT

PLED

## ULC0544P10-MS

## **Product specification**





#### Features

- Ultra low leakage: nA level
- Operating voltage: 5.0V
- Low clamping voltage
- Complies with following standards:
  - IEC 61000-4-2 (ESD) immunity test
    Air discharge: ±30kV
  - Contact discharge: ±25kV
  - IEC61000-4-4 (EFT) 40A (5/50ns)
  - IEC61000-4-5 (EFT) 5A
  - (8/20ns) RoHS Compliant

#### **Applications**

- USB 2.0 power and data line
- Set-top box and digital TV
- Digital video interface (DVI)
- Notebook Computers
- SIM Ports
- 10/100 Ethernet

#### **Mechanical Characteristics**

- Package: DFN2510P10
- Lead Finish: Lead Free
- UL Flammability Classification Rating 94V-0
- Quantity Per Reel:3,000pcs
- Reel Size:7 inch

#### **Reference News**

PACKAGE OUTLINE	Pin Configuration	Marking
	NC NC GND NC NC 10 $9$ $8$ $7$ $610$ $2$ $3$ $4$ $51/0_1 1/0_2 GND 1/0_3 1/0_4$	• P524
DFN2510P10		



#### Absolute Maximum Ratings(Tamb=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit	
Peak Pulse Power (8/20µs)	Ррр	150	W	
ESD per IEC 61000-4-2 (Air)	Vesd	±15	Kv	
ESD per IEC 61000-4-2 (Contact)	VESD	±8		
Operating Temperature Range	TJ	-55 to + 125	°C	
Storage Temperature Range	Тѕтј	-55 to + 150	°C	

### Absolute Maximum Ratings (TA=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Peak Pulse Power (8/20µs)	Ppk	150	W
Peak Pulse Current (8/20µs)	IPP	5	А
ESD per IEC 61000-4-2 (Air) ESD per IEC 61000-4-2 (Contact)	Vesd	±30 ±25	V
Operating Temperature Range	TJ	-55 to +125	°C
Storage Temperature Range	Tstg	-55 to +150	°C

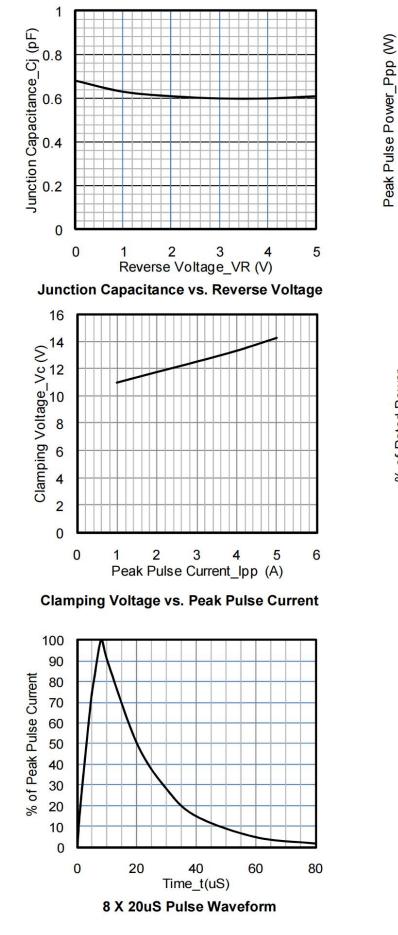
#### Electrical Characteristics (TA=25°C unless otherwise specified)

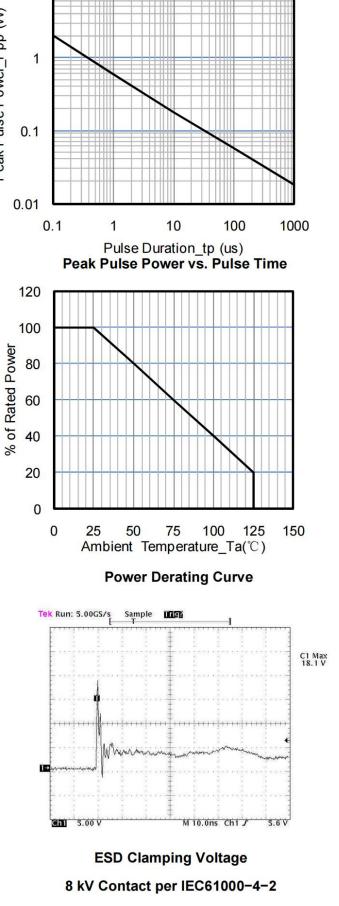
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Reverse Working Voltage	VRWM			5	V	Any I/O pin to ground
Breakdown Voltage	VBR	6			V	IT = 1mA, any I/O pin to ground
Reverse Leakage Current	I <sub>R</sub>			0.5	ųA	VRWM = 5V, any I/O pin to ground
Clamping Voltage	Vc			15	V	IPP = 1A (8 x 20µs pulse), any I/O pin to ground
Clamping Voltage	Vc			20	V	IPP = 5A (8 x 20µs pulse), any I/O pin to ground
Junction Capacitance	CJ		0.3	0.4	pF	VR = 0V, f = 1MHz, between I/O pins
Junction Capacitance	CJ			0.8	pF	VR = 0V, f = 1MHz, any I/O pin to ground



#### Typical Performance Characteristics (TA=25°C unless otherwise Specified)

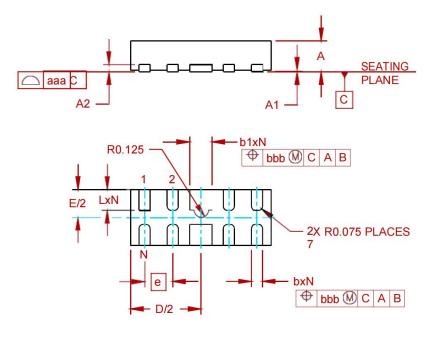
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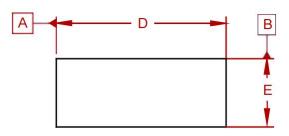






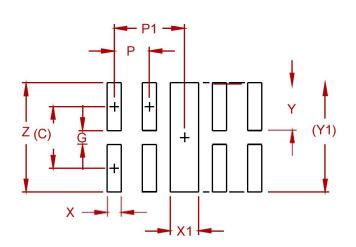
#### PACKAGE MECHANICAL DATA





	DIMENSI			ONS		
DIM	INCHES			MILLIMETERS		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
А	.020	.023	.026	0.50	0.58	0.65
A1	0.00	.001	.002	0.00	0.03	0.05
A2	(.005)			(0	. 13)	
b	.006	.008	.010	0.15	0.20	0.25
1	.014	.016	.018	0.35	0.40	0.45
D	.094	.098	. 102	2.40	2.50	2.60
Е	.035	.039	.043	0.90	1.00	1. 10
е	.020 BSC			0.5	0 BSC	
L	.012	.015	.017	0.30	0.38	0.425
Ν	8				8	
aaa	.003			0.08		
bbb	.004			0. 10		

#### Suggested Pad Layout



	DIMENSIONS					
DIM	INCHES	MILLIMETERS				
С	(.034)	(0.875)				
G	.008	0.20				
Р	.020	0.50				
P1	.039	1.00				
Х	.008	0.20				
X1	.016	0.40				
Y	.027	0.675				
Y1	(.061)	( 1.55)				
Z	.061	1.55				

#### NOTES:

CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES). THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY. CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
ULC0544P10-MS	DFN2510P10	3000



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